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BUK7E07-55B

N-channel TrenchMOS standard level FET

Rev. 01 — 29 January 2008

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode power Field-Effect Transistor (FET) in a plastic package using NXP High-Performance Automotive (HPA) TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in Automotive critical applications.

1.2 Features

- Very low on-state resistance
- 175 °C rated

- Q101 compliant
- Standard level compatible

1.3 Applications

- Automotive systems
- Motors, lamps and solenoids
- General purpose power switching
- 12 V and 24 V loads

1.4 Quick reference data

- \blacksquare E_{DS(AL)S} \leq 351 mJ
- $I_D \le 75 A$

- \blacksquare R_{DSon} = 5.8 mΩ (typ)
- Arr P_{tot} \leq 203 W

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Symbol
1	gate (G)		_
2	drain (D)	mb	D
3	source (S)		
3 mb	mounting base; connected to drain (D)		mbb076 S
		SOT226 (I2PAK)	



3. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BUK7E07-55B	I2PAK	plastic single-ended package (I2PAK); low-profile 3-lead TO-220AB	SOT226

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage			-	55	V
V_{DGR}	drain-gate voltage (DC)	R_{GS} = 20 k Ω		-	55	V
V_{GS}	gate-source voltage			-	±20	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 2</u> and <u>3</u>	<u>[1]</u>	-	119	Α
			[2]		75	Α
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u>	[2]	-	75	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3		-	478	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	203	W
T _{stg}	storage temperature			-55	+175	°C
Tj	junction temperature			-55	+175	°C
Source-d	rain diode					
I_{DR}	reverse drain current	T _{mb} = 25 °C	[2]	-	75	Α
I _{DRM}	peak reverse drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$		-	478	Α
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	Unclamped inductive load; I_D = 75 A; $V_{DS} \le$ 55 V; V_{GS} = 10 V; R_{GS} = 50 Ω ; starting at T_j = 25 °C		-	351	mJ
E _{DS(AL)R}	repetitive drain-source avalanche energy	Repetitive rating defined in Figure 16	[3]	-	-	J

^[1] Current is limited by chip power dissipation rating.

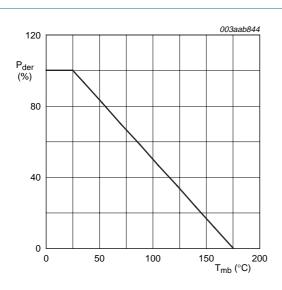
- a) Maximum value not quoted.
- b) Single-pulse avalanche rating limited by $T_{j(\text{max})}$ of 175 $^{\circ}\text{C}.$
- c) Repetitive avalanche rating limited by an average junction temperature of 170 $^{\circ}\text{C}.$
- d) Refer to application note AN10273 for further information.

^[2] Continuous current is limited by package.

^[3] Conditions:

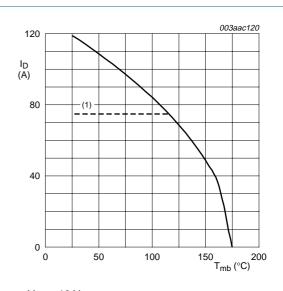
BUK7E07-55B

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 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$

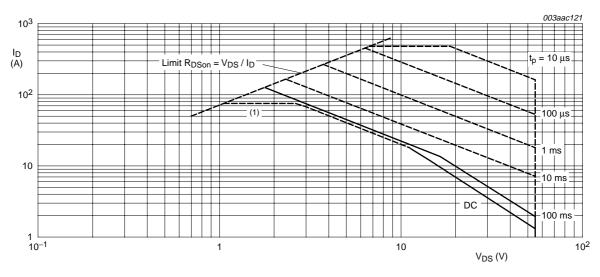
Fig 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$

(1) Capped at 75 A due to package.

Fig 2. Continuous drain current as a function of mounting base temperature



 T_{mb} = 25 °C; I_{DM} is single pulse.

(1) Capped at 75 A due to package.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

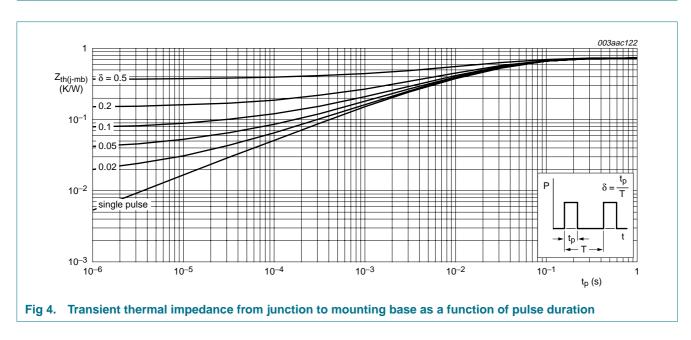
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5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	-	-	-	0.74	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W



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6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	55	-	-	V
		T _j = −55 °C	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; see Figure 9 and 10				
		T _j = 25 °C	2	3	4	V
		T _j = 175 °C	1	-	-	V
		T _j = −55 °C	-	-	4.4	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	0.02	1	μΑ
		T _j = 175 °C	-	-	500	μΑ
I _{GSS}	gate leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; \text{ see } \frac{\text{Figure 6}}{\text{6}} \text{ and } \frac{8}{\text{C}}$				
		T _j = 25 °C	-	5.8	7.1	mΩ
		T _j = 175 °C	-	-	14.2	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u>	-	53	-	nC
Q _{GS}	gate-source charge		-	12	-	nC
Q_{GD}	gate-drain charge			17	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$ see Figure 12	-	2820	3760	pF
C _{oss}	output capacitance		-	554	665	pF
C _{rss}	reverse transfer capacitance			200	274	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega;$	-	24	-	ns
t _r	rise time	V_{GS} = 10 V; R_G = 10 Ω	-	52	-	ns
t _{d(off)}	turn-off delay time		-	77	-	ns
t _f	fall time		-	41	-	ns
L _D	internal drain inductance	measured from drain lead 6 mm from package to centre of die	-	4.5	-	nΗ
L _S	internal source inductance	measured from source lead to source bond pad	-	7.5	-	nΗ
Source-d	rain diode	·				
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; see Figure 15	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s};$	-	62	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{R} = 30 \text{ V}$		60	-	nC

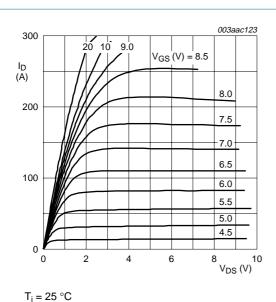


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

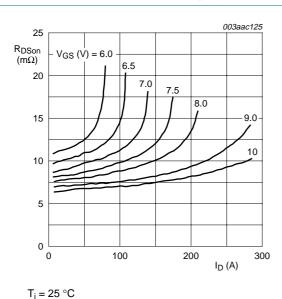


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

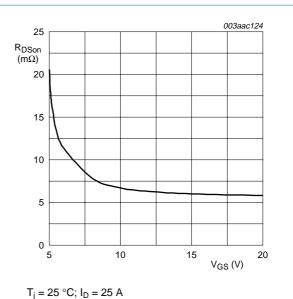


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

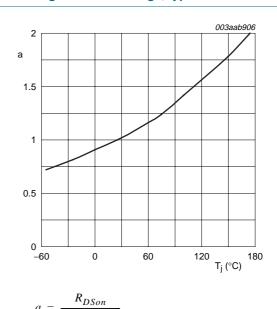
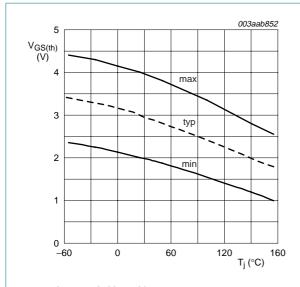
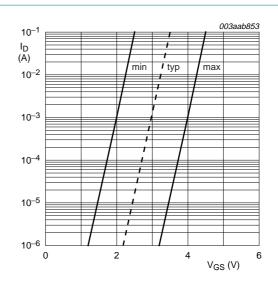


Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



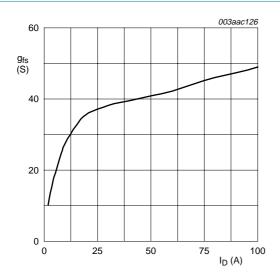
 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



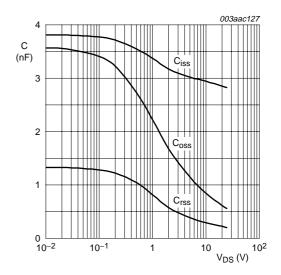
 $T_j = 25 \, ^{\circ}C; \, V_{DS} = V_{GS}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_j = 25 \,^{\circ}C; \, V_{DS} = 25 \,^{\circ}V$

Fig 11. Forward transconductance as a function of drain current; typical values



 $V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

 $V_{DS} = 25 \text{ V}$

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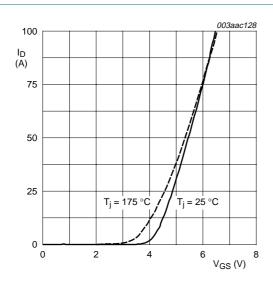
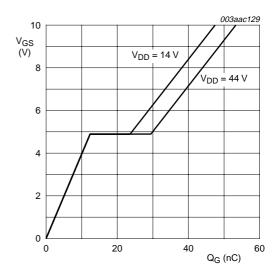


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $T_i = 25 \,^{\circ}C; I_D = 25 \,^{\circ}A$

Fig 14. Gate-source voltage as a function of gate charge; typical values

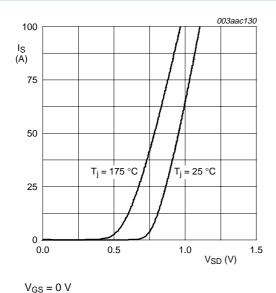
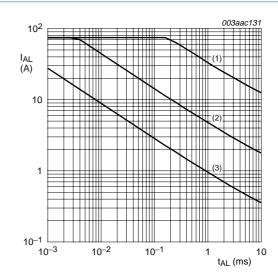


Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



See Table note 3 of Table 3 Limiting values.

- (1) Single-pulse; T_i = 25 °C.
- (2) Single-pulse; $T_i = 150 \,^{\circ}\text{C}$.
- (3) Repetitive.

Fig 16. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time

7. Package outline

Plastic single-ended package (I2PAK); low-profile 3-lead TO-220AB

SOT226

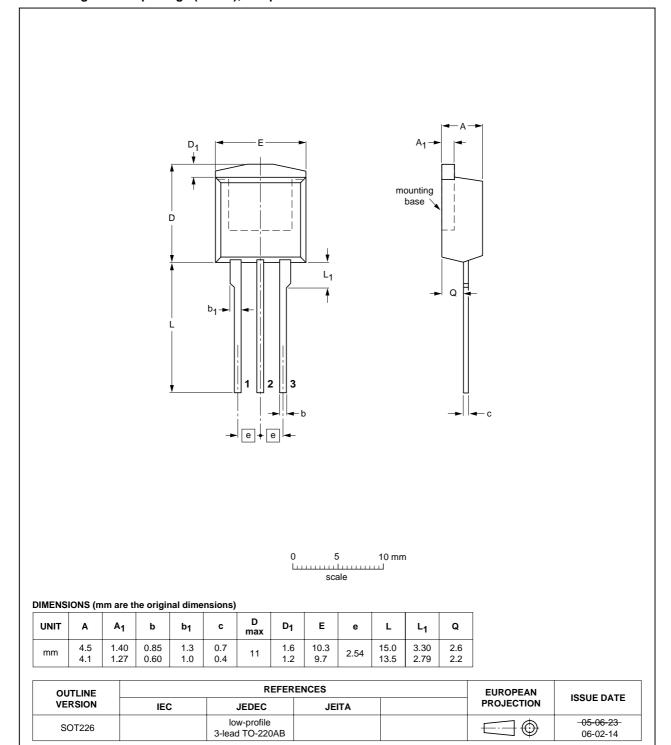


Fig 17. Package outline SOT226 (I2PAK)



8. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7E07-55B_1	20080129	Product data	-	-

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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